



Influence of surface nanostructure on wetting properties

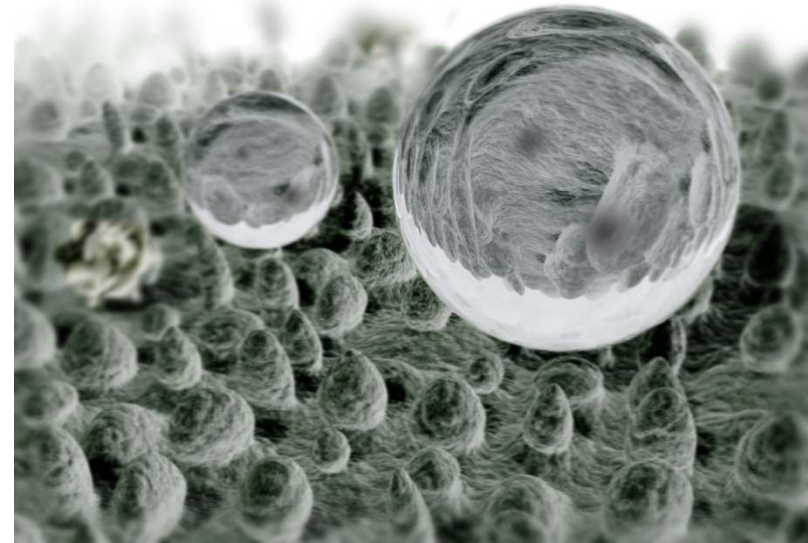
Mika Lindén

Center for Functional Materials, Department of
Physical Chemistry, Åbo Akademi University



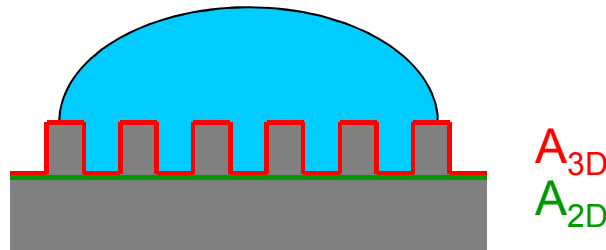
Introduction

- Wettability is an important phenomenon in many industrial processes, e.g. adhesion, printing, self-cleaning surfaces etc.
- The wettability of a surface is governed by the chemistry and the morphology of the surface.
- A classical example is the self-cleaning properties of the lotus leaf (ref. Barthlott, W., Neinhuis, C. *Planta* **1997**, 202, 1-8)



***How to model wetting of nanopatterned surfaces?
How can we utilize wetting for optimized printing aquality?***

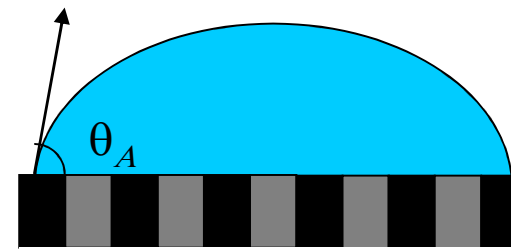
Wetting of rough and heterogeneous surfaces



$$\cos \theta_A = r \cos \theta_Y$$

$$r = A_{3D}/A_{2D}$$

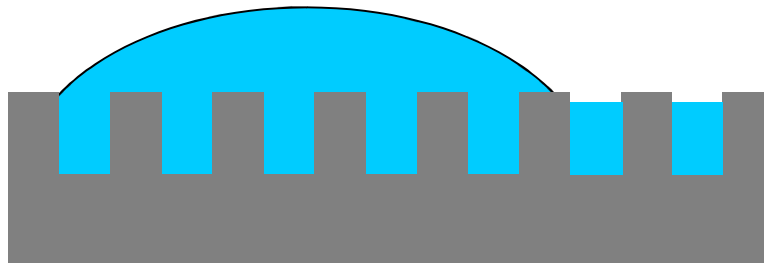
Wenzel



$$\cos \theta_A = f_1 \cos \theta_1 + f_2 \cos \theta_2$$

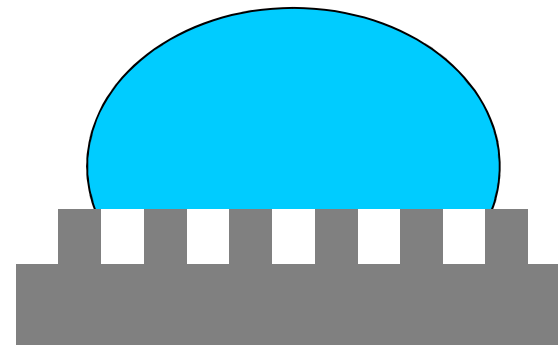
Cassie

Wetting of rough and multicomponent surfaces



$$\cos \theta_A = f_S \cos \theta_S + (1 - f_S)$$

Bico



$$\cos \theta_A = f_S \cos \theta_S - (1 - f_S)$$

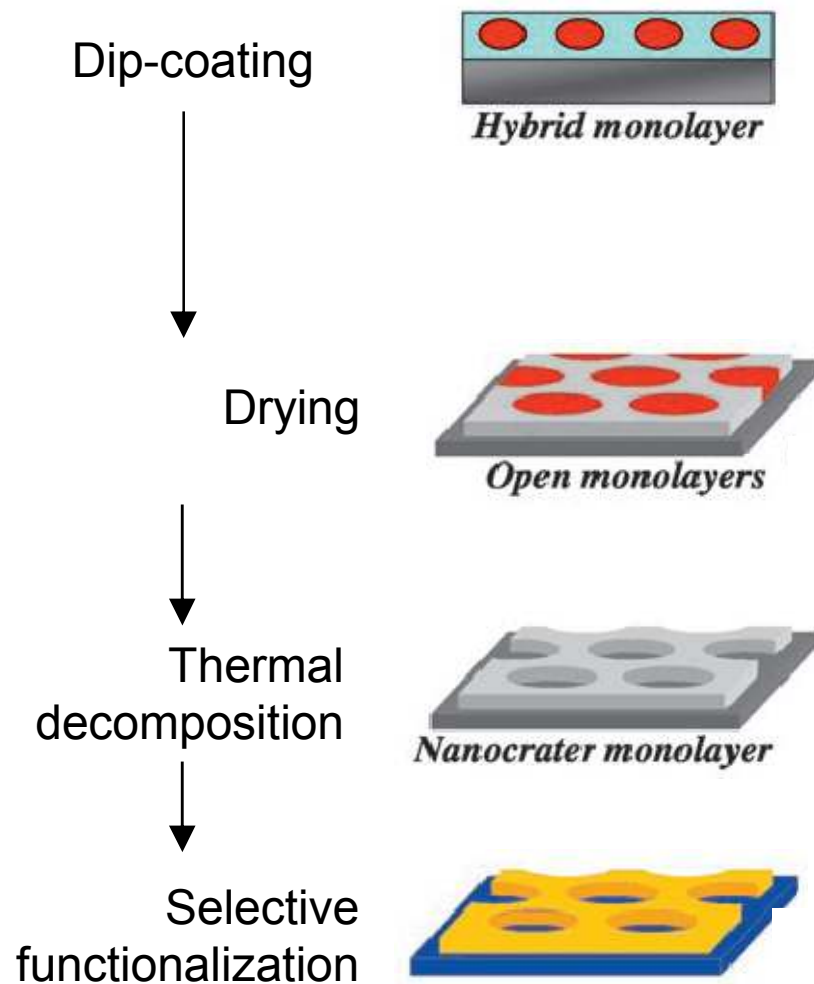
Cassie-Baxter

Contact angle hysteresis!



Evaluation of wetting theories for nanometer-length scale heterogeneities

Synthesis of model substrates



The pore diameter can be tuned between 10 and 50 nm depending on the size of the block-copolymer used as the template.

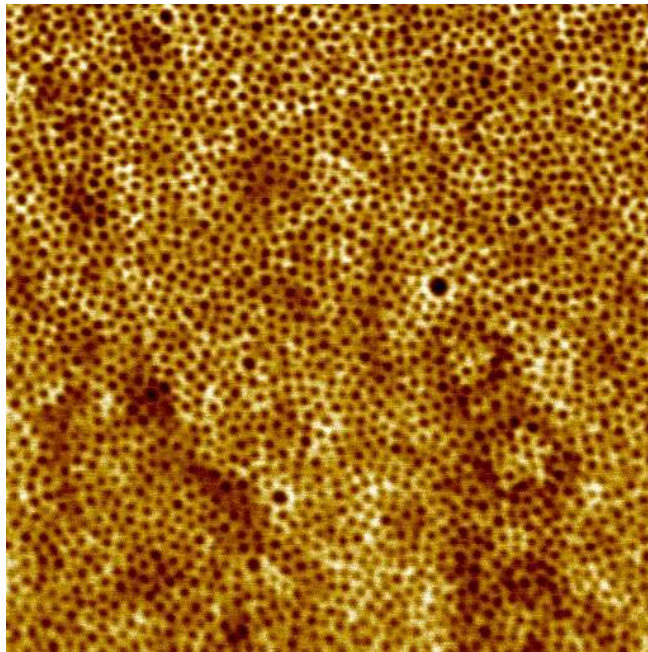
Pores are aligned perpendicular to the substrate, which make these films ideal for applications related to microelectronics and sensing, to name a few.

The substrate (SiO_2 or Au) is accessible through the craters.

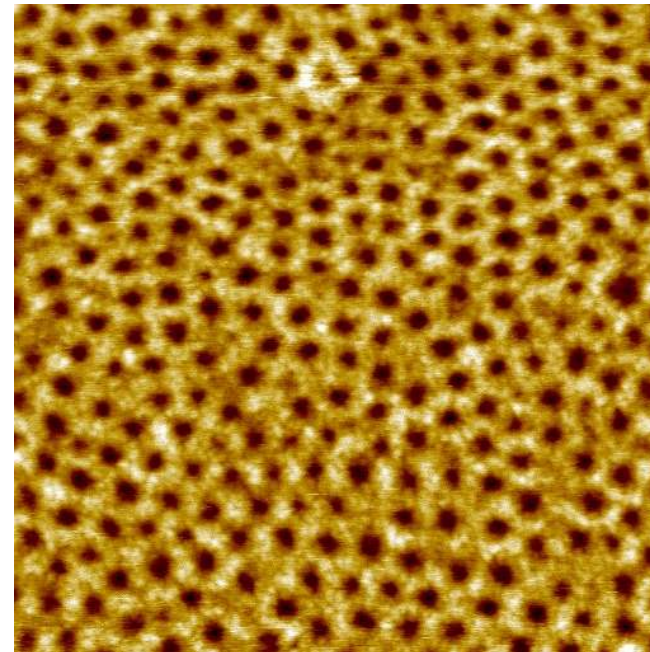
A. Fisher, M. Kuemmel, M. Järn, M. Linden, C. Boissière, L. Nicole, C. Sanchez, D. Grosso, *Small* **2006**, 2, 569.

Nanopatterned $\text{TiO}_2@ \text{SiO}_2$

$3 \mu\text{m} \times 3 \mu\text{m}$



$1 \mu\text{m} \times 1 \mu\text{m}$

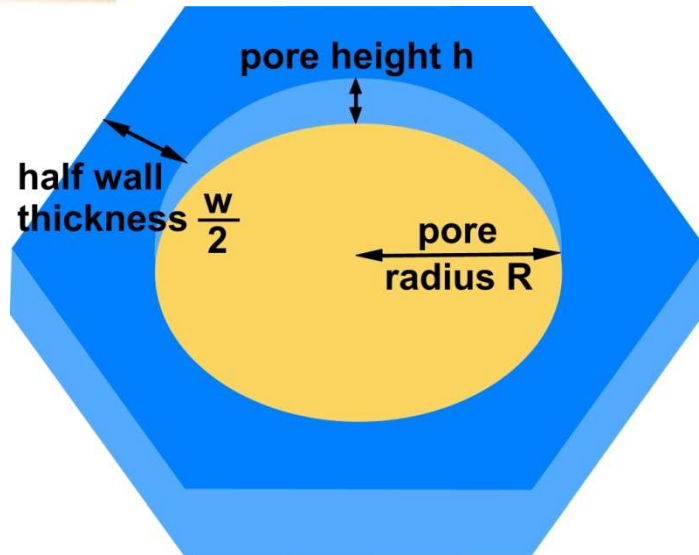


Pore diameter $\approx 30 \text{ nm}$

Wall thickness $\approx 30 \text{ nm}$

Layer thickness $\approx 2 \text{ nm}$

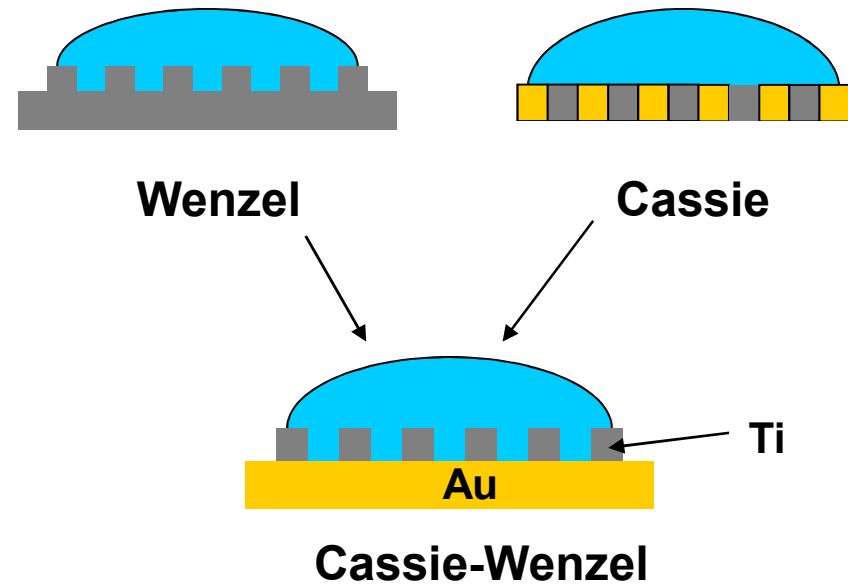
Determination of critical parameters



f and r values are determined from one unit cell (AFM, SEM, ellipsometry)

$$f_{TiO_2-2D} = 1 - \frac{\pi R^2}{2\sqrt{3} \left(R + \frac{w}{2}\right)^2}$$

$$r = 1 + \frac{2\pi R h}{2\sqrt{3} \left(R + \frac{w}{2}\right)^2 - \pi R^2}$$



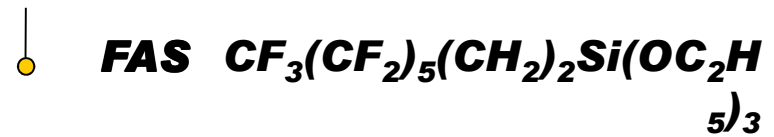
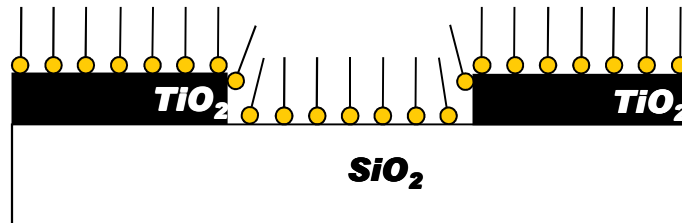
$$\cos \theta_A = F_{Ti} \cos \theta_{Ti} + F_{Au} \cos \theta_{Au}$$

$$F_{Ti} = \frac{r \cdot f_{Ti}}{r \cdot f_{Ti} + f_{Au}} \quad F_{Au} = \frac{f_{Au}}{r \cdot f_{Ti} + f_{Au}}$$

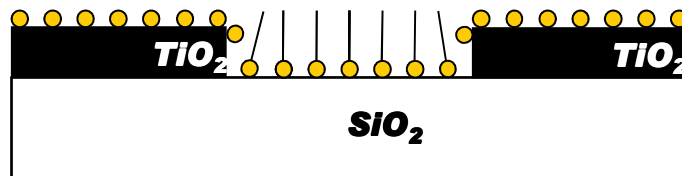
Variation of f-values



FAS
functionalization

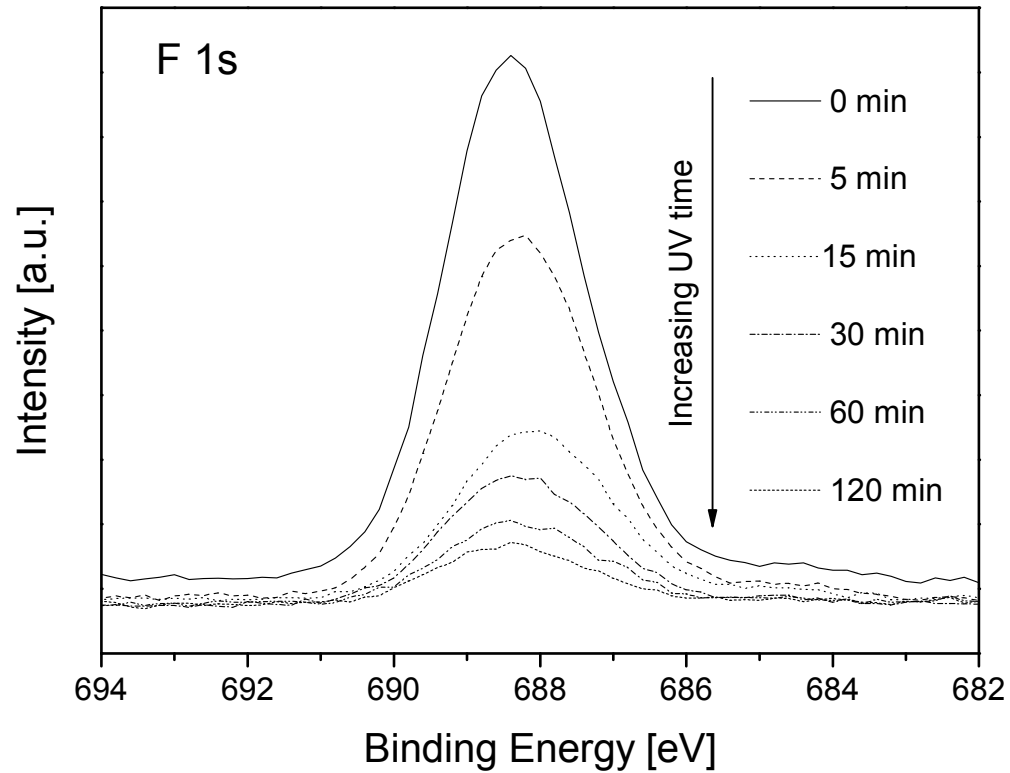


UV light



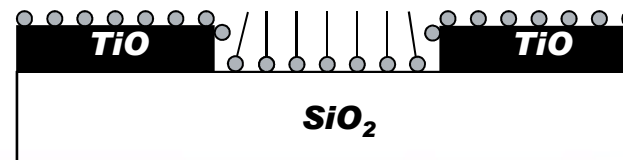
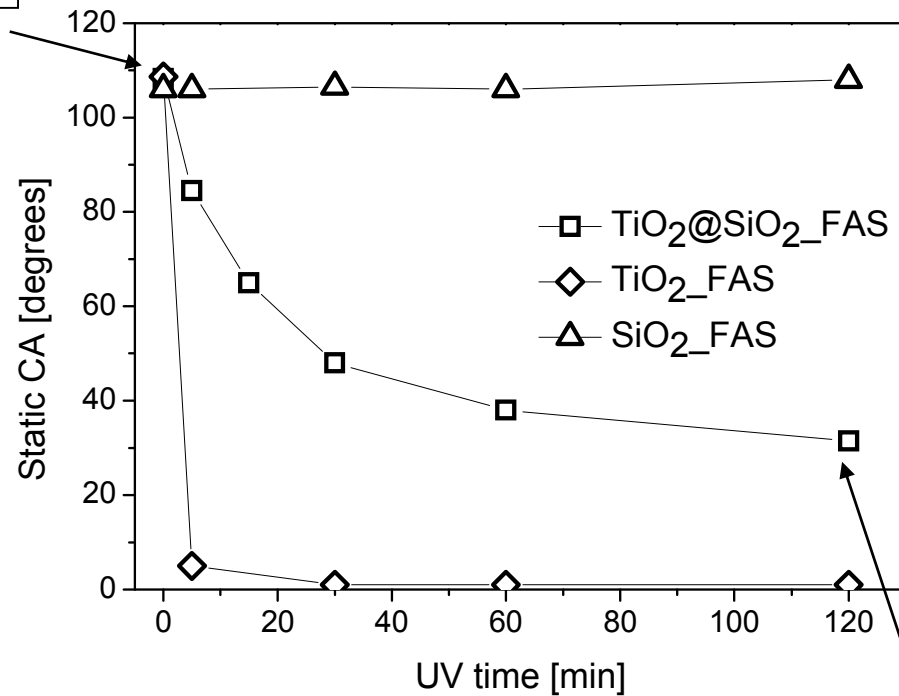
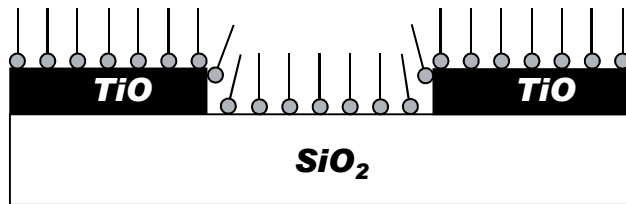
● **Siloxane headgroup**

Verification of f-values



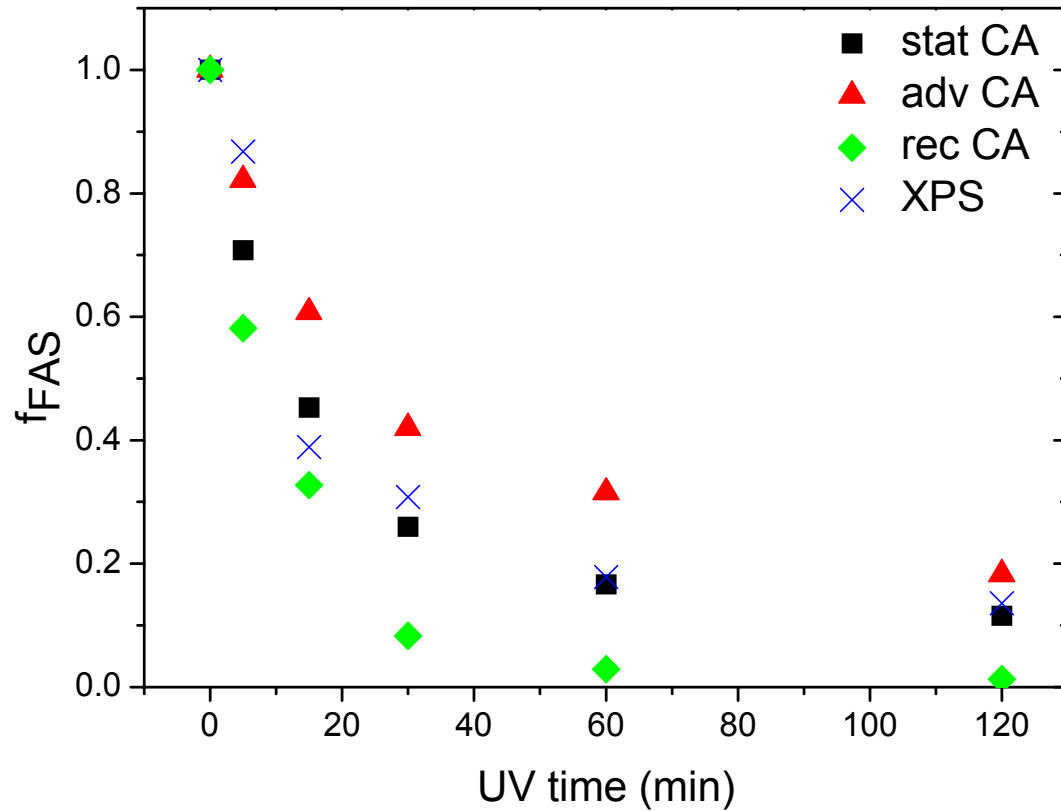
UV time [min]	0	5	15	30	60	120
F/Ti	2.34	2.03	0.91	0.72	0.42	0.32
f_{FAS}	1	0.87	0.39	0.31	0.18	0.14

Contact angle results



M. Järn, Q. Xu, M. Lindén, *Langmuir*, In Press

Static contact angle gives the best agreement!



f_{FAS} values calculated from the static CA give a good agreement with the XPS data



Applied wetting studies

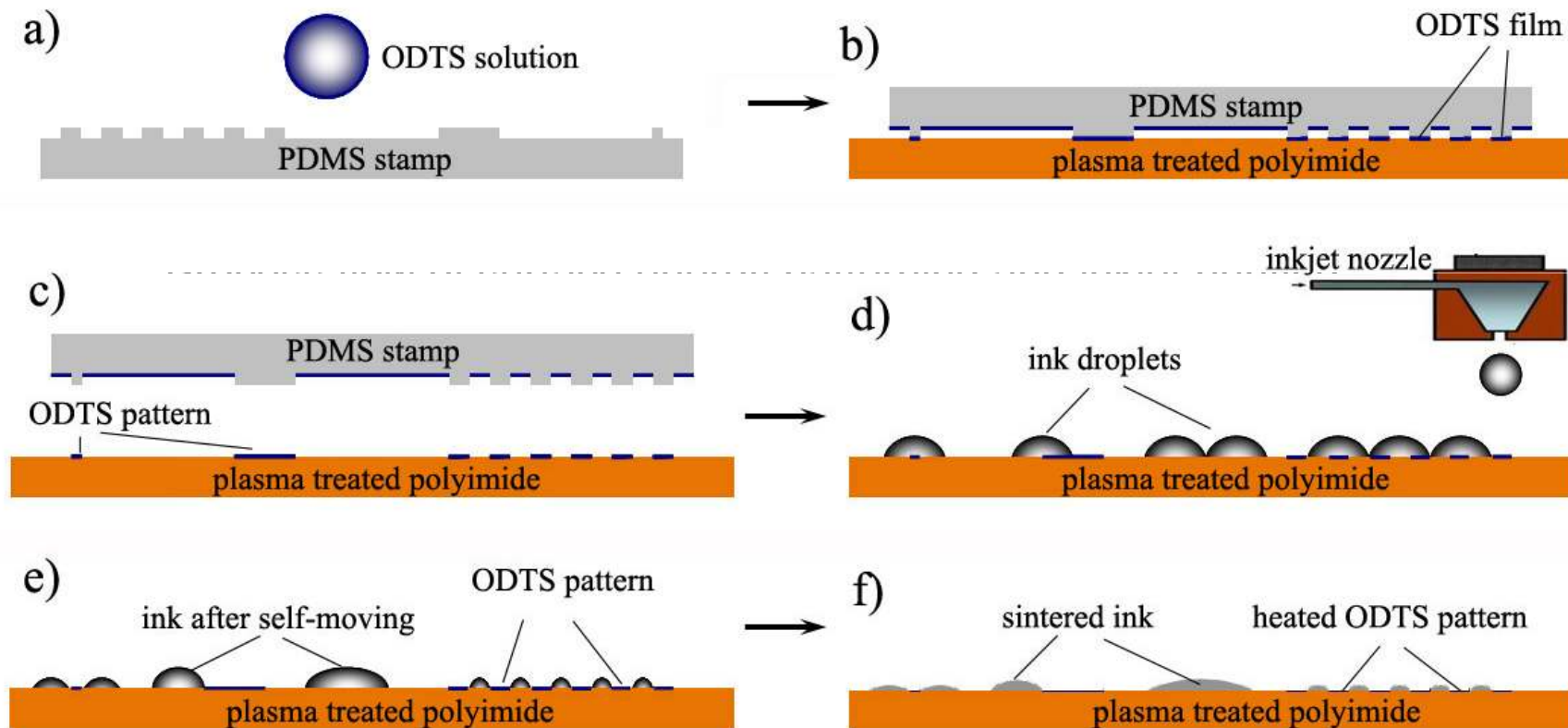


Goal: higher resolution in inkjet printing

- Normally resolution is 35-100 μm , 20 μm is the limitation for most inkjet printing.
- OFET channels require controlled geometries below 20 μm
 - Shorter channels lead to higher performance,
 - Less material consumption
- One of the most challenging issues for inkjet printing technology.

Our method: stamping

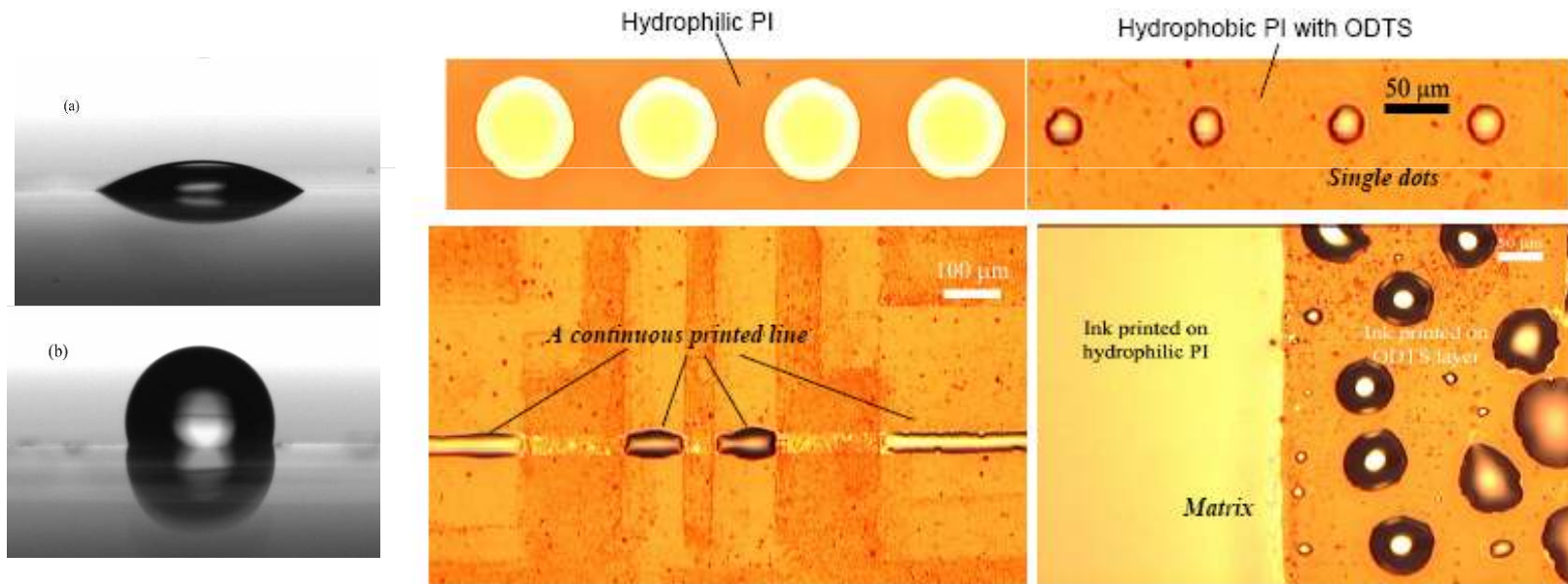
Stamping: a fast and easy way to replicate patterns generated by photolithography ($\geq 1\mu\text{m}$), electron beam lithography (nm), or other methods.



Inkjet printing results

Surface energy patterning controls print quality in printed electronics

- For better control of quality
- For increased resolution

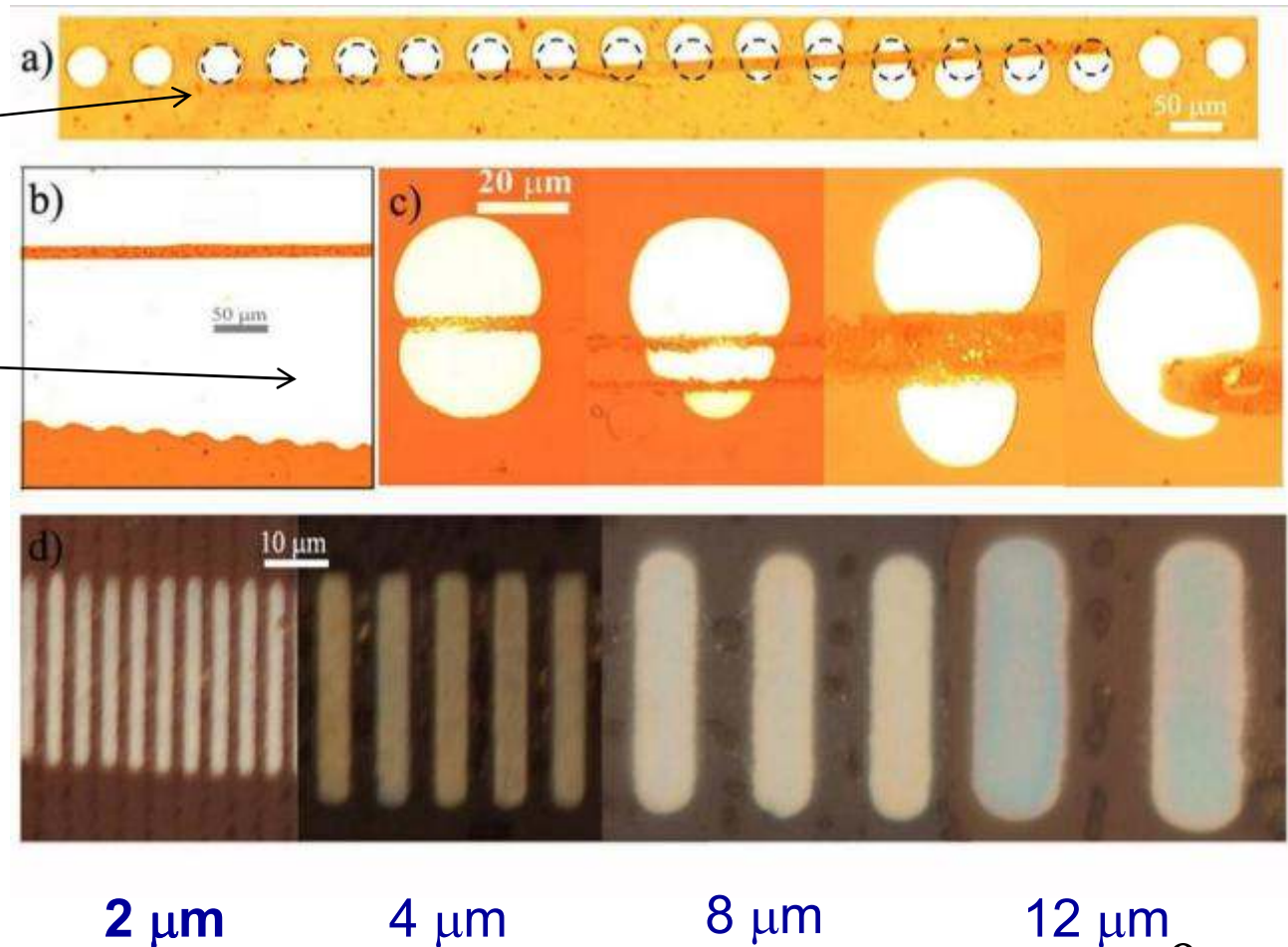


Water contact angle

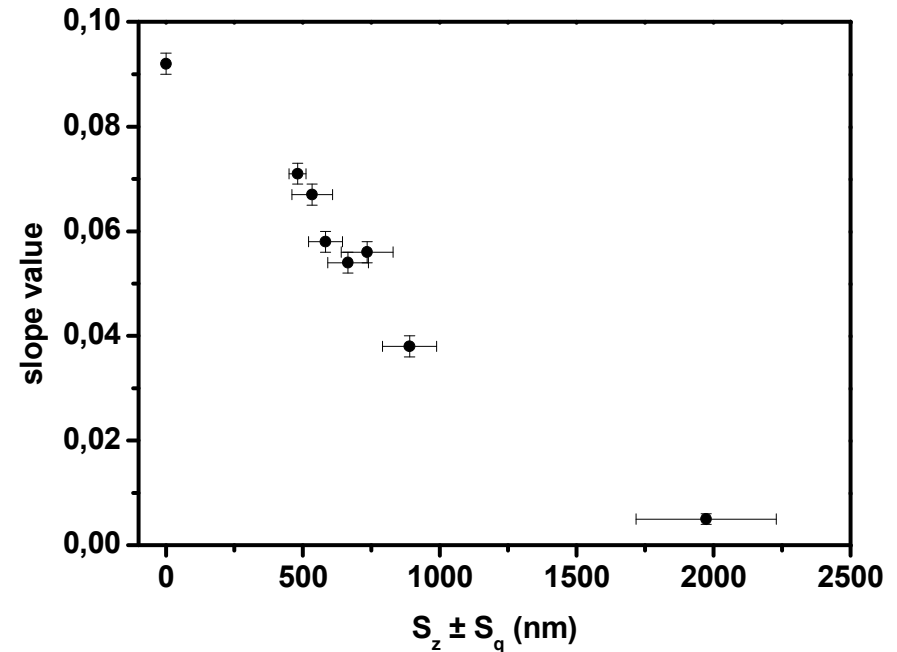
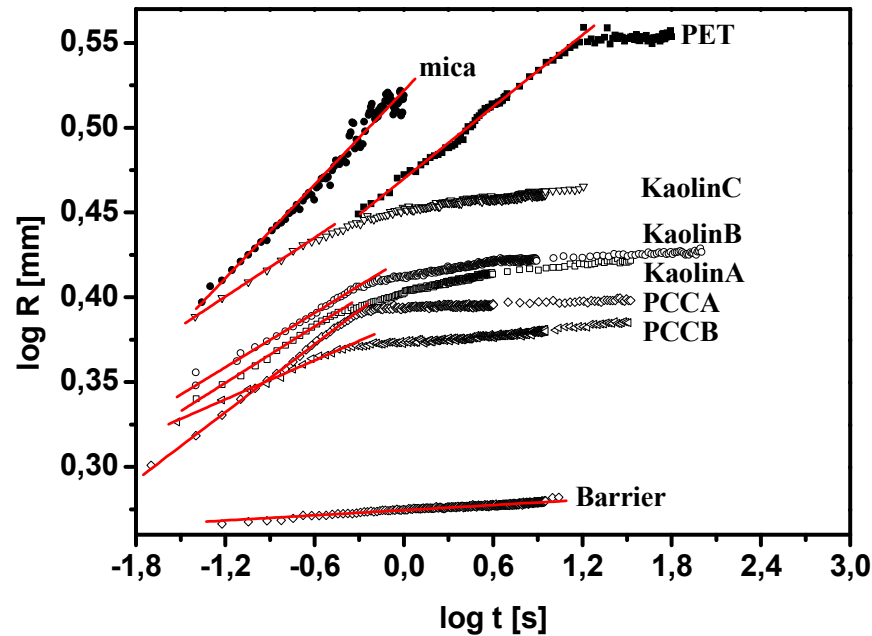
Comparison of ink printed (dots, line, and plane) between areas with ODTs layer and without ODTs layer

Inkjet printing results

- Surface pattern controls print quality
- Patterning gives better control over printed edges compared to non-patterned
- Better resolution!
- **Resolution limited by stamp fabrication!**
- Good for making short channel length devices



Wetting kinetics of o-DCB* on coated paper



- Maximal spreading of inkjet droplets (radius R) of o-DCB* is dependent on roughness, surface energy, pore volume and geometry of the paper coating.
- The wetting rate (slope) correlates with the magnitude of surface extremes (asperities, S_z).

*ortho-dichlorobenzene , a typical solvent for semiconductor P3HT



Conclusions

- Detailed wetting studies on well-characterized nanopatterned surfaces suggest that the static contact angle is the most reliable measure of surface heterogeneities when on the nanometer length scale
- Rational substrate optimizations for printing can be performed for enhanced print-resolution for preparation of advanced structures
- Surface structure, polarity, and porosity do all have to be taken into account for optimized spreading. However, surface topography has an almost linear influence on the wetting rate.